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High Resolution Electromechanical Imaging of Ferroelectric Materials in a Liquid Environment by Piezoresponse Force Microscopy

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High-resolution imaging of ferroelectric materials using piezoresponse force microscopy (PFM) is demonstrated in an aqueous environment. The elimination of both long-range electrostatic forces and capillary interactions results in a localization of the ac field to the tip-surface junction and allows the tip-surface contact area to be controlled. This approach results in spatial resolutions approaching the limit of the intrinsic domain-wall width. Imaging at frequencies corresponding to high-order cantilever resonances minimizes the viscous damping and added mass effects on cantilever dynamics and allows sensitivities comparable to ambient conditions. PFM in liquids will provide novel opportunities for high-resolution studies of ferroelectric materials, imaging of soft polymer materials, and imaging of biological systems in physiological environments on, ultimately, the molecular level.

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Electromechanical coupling is ubiquitous among inorganic materials and biological systems. In the latter case, piezoelectricity is linked to physiological structure and biochemical functionality. The combination of polar bonding and optical activity results in a piezoelectric response comparable to quartz (≈ 1–3 pm/V) in virtually all bio-polymers [1]. The ability to probe electromechanical coupling on the molecular scale in living biosystems will improve the understanding of piezoelectric biofunctionality and pave the way for advances in molecular electromechanical systems.

A key tool for probing electromechanical coupling on the nanoscale is piezoresponse force microscopy (PFM), which is based on the direct measurement of local electromechanical coupling in a piezoelectric material using a periodically biased atomic force microscope (AFM) tip [2,3]. PFM has been established as a powerful tool for investigating low-dimensional ferroelectrics for nonvolatile memory devices [4,5] and data storage applications [6,7]. A number of recent advances have been enabled by PFM, including the identification of the origins of ferroelectricity in ferroic superlattices [8,9], the mechanisms of magnetoelectric coupling and polarization switching in multiferroic nanostructures [10], the statistical physics of domain walls in ferroelectrics [11], and the structure of polar nanodomains in ferroelectric relaxors [12]. Recent improvements in PFM sensitivity have permitted the investigation of a wide variety of weakly piezoelectric materials such as III-nitride thin films [13] and biopolymers in calcified and connective tissues [14,15] with up to 10 nm resolution. However, in order to address electromechanical phenomena in biological systems, probe electroactive soft condensed matter systems, and perform high-resolution studies of ferroelectric perovskites, a fundamentally different approach to PFM is required that minimizes both the electrostatic interactions and the tip-surface forces. Here, we explore PFM imaging in a liquid environment [16] as a means to control these detrimental mechanisms [17] and ultimately probe electromechanical coupling on the molecular level. The successful demonstration of liquid electromechanical imaging on a model ferroelectric system enables these future studies.

Achieving the goal of single-molecule electromechanical imaging in liquids requires an improvement in the resolution and sensitivity of PFM, ideally to the nanometer level in ferroelectric perovskites and to the molecular level in ferro- and piezoelectric polymers. Three factors limiting the resolution of PFM are (a) electrostatic contributions to the signal, (b) large (> 100 nN) tip-surface forces present in contact mode imaging, and (c) capillary forces due to condensed atmospheric moisture. The quadratic bias dependence of electrostatic forces on the cantilever present during PFM measurements does not allow the electromechanical response, which has a linear bias dependence, to be distinguished unambiguously from the electrostatics. The electrostatic effects can be minimized by using stiff cantilevers, but at the expense of larger indentation forces and reduced resolution [18].

Liquid PFM was implemented on a commercial AFM system (Veeco MultiMode NS-IIIa) equipped with additional function generators and lock-in amplifiers (DS 345, SRS 830, and SRS 844, Stanford Research Instruments, and Model 7280, Signal Recovery) and an external signal generation and data acquisition system. A custom-modified commercial liquid cell (Veeco) was used to bias the tip directly during contact mode operation in liquid. Measurements were performed using Au coated Si tips (Micromasch, spring constant k ≈ 0.3 N/m). Electromechanical imaging of a model polycrystalline lead zirconate-titanate (PZT) ceramics (95:5 Zr/Ti composition) was performed in distilled water and NaCl solutions. As in air, liquid PFM measurements were performed by applying a modulation voltage to a tip in contact with a piezoelectric surface. The electric field generated at the tip-
surface junction deforms the piezoelectric surface, thereby deflecting the tip. The amplitude and phase of the tip oscillation were recorded simultaneously with surface topography. The PFM amplitude is proportional to the tip deflection (surface displacement) while the phase contains information about the orientation of the polarization of the material beneath the tip. Shown in Fig. 1 are surface topography, PFM amplitude, and PFM phase images of PZT acquired in distilled water at 629 kHz. The topographic structure is related to the domain orientation as revealed by preferential etching. The mixed signal and phase profile across a typical domain wall contains information on the orientation of the material. PFM amplitude and phase images obtained at various positions along the force-distance curve are shown in Fig. 2. Note that, while the PFM contrast is virtually constant for indentation forces from 48 to 18 nN, the signal rapidly decreases from 3 to 0 nN and disappears at −4.5 nN, corresponding to a loss of tip-surface contact. In comparison, in ambient PFM, an increase in the tip-surface separation results in a marked discontinuity between an electromechanical (in contact) to a purely electrostatic (noncontact) behavior [20]. Any electrostatic contrast apparent under ambient conditions in the noncontact regime is absent when imaging in liquid.

The dynamic behavior of the cantilever was investigated using amplitude-frequency and amplitude-bias spectroscopy as illustrated in Fig. 3(a). At low frequencies, the PFM response in liquid is reduced by more than an order of magnitude as compared to ambient and the first resonant peak is shifted (from 83.64 to 217.77 kHz) and damped ($Q = 7$ in liquid vs 20 in air). For high-order resonances, the $Q$ factor increases, achieving $Q_i = 13.6$ for $i = 3$. This is due to a reduction in the volume of liquid excited by the cantilever at higher-order resonances and results in diminished viscous damping [21]. In particular, the maximum signal at the second resonance in liquid is within a factor of 2 of the 1st ambient resonance. Thus, resonant enhancement at high-order modes in liquid is possible and the measured sensitivity is comparable to that in ambient. The PFM signal was also measured as a function of dc bias. The amplitude-frequency response curves do not change when a dc bias is applied to the tip indicating the absence of an electrostatic contribution to the signal [22].

To determine the effects of the Debye length on the PFM signal amplitude, i.e., the screening range of the electrostatic forces in the solution, PFM imaging and amplitude-
frequency spectroscopy were performed in NaCl solutions with concentrations of $10^{-4}$, $10^{-3}$, $10^{-2}$, and $10^{-1}$ M. The corresponding Debye lengths, $\lambda_D = \sqrt{\varepsilon_\varepsilon_0 k_B T / \varepsilon e^2} = 0.304 / \sqrt{C}$ nm (for 1:1 electrolytes), are 30.4, 9.6, 3.04, and 0.96 nm. The relaxation frequency (1.8 MHz for a 10$^{-4}$ M NaCl solution) is sufficiently high to ensure efficient screening. PFM images for various salt concentrations (not shown) exhibit robust PFM contrast in a 10$^{-4}$ M solution, contrast deterioration in 10$^{-3}$ and 10$^{-2}$ M solutions, and no contrast in the 10$^{-1}$ M solution. The corresponding PFM amplitude-frequency curves for a cantilever in solutions with varying salt concentrations are illustrated in Fig. 3(b).

From these observations, the following picture of PFM imaging in liquid vs ambient environment emerges. In an ambient environment, the tip interacts with the surface through electrostatic forces and short-range electromechanical interactions. The piezoresponse (PR) signal, i.e., the first harmonic component of tip oscillation induced by a periodic bias applied to the tip, is

$$\text{PR} = \text{PR}_{em} + \text{PR}_{el},$$

In the low-frequency limit, the electromechanical response is [22]

$$\text{PR}_{em} = \alpha_d(h) \tilde{d}_{33} \frac{k_1}{k_1 + k},$$

where $\tilde{d}_{33}$ is the electromechanical response of material, $\alpha_d(h)$ is the ratio of the ac tip potential to the ac surface potential of the ferroelectric (i.e., the potential drop in the tip-surface gap), $k_1$ is the spring constant of the tip-surface junction, and $k$ is the spring constant of the cantilever. In ambient or vacuum, the electrostatic forces are long range, $F_{el}^{amb} = (1/2)C'(z)(V_d - V_s)^2$, where $V_d$ is the tip potential, $V_s$ is the surface potential, and $C'(z)$ is the tip-surface capacitance gradient. The electrostatic contribution is thus

$$\text{PR}_{el}^{amb} = \left( C'_{sphere} + \frac{C'_{cone}'}{k_1 + k} + \frac{C'_{cant}}{24k} \right) (V_d - V_s).$$

where $R$ is the tip radius of curvature. In ambient, $\alpha_d(h) = 1$ for $h < 0$ (contact), i.e., the response is independent of the penetration depth [23] and $\alpha_d(h) \ll 1$ for $h > 0$ (noncontact), giving rise to the well-known limits of PFM and Kelvin probe force microscopy. As shown in Figs. 4(a) and 4(b), the capacitive tip-surface electrostatic interaction is present for both noncontact and contact modes of operation. However, the electromechanical coupling is present only in the contact mode [double arrow in Fig. 4(b)].

In liquid, the PFM contrast is strongly mediated by the presence of mobile ions that screen electrostatic tip-surface interactions. For the sphere-plane system [24]

$$F_{el}^l(z) = \frac{\epsilon_0 \varepsilon_0 R}{\lambda_D} \frac{2V_s \exp(h/\lambda_D) - (V_s^2 + V_t^2)}{\exp(2h/\lambda_D) - 1}. \quad (4)$$

Electrostatic interaction in liquid is short-range due to screening by mobile ions and decays exponentially for $h > \lambda_D$ [Figs. 4(c) and 4(d)]. Thus, the electrostatic contribution to the PFM signal in liquid is (for $h > 0$)

$$\text{PR}_{el}^l = \frac{\epsilon_0 \varepsilon_0 R}{\lambda_D} \frac{2V_s \exp(h/\lambda_D)}{\exp(2h/\lambda_D) - 1} \frac{1}{k_1 + k}. \quad (5)$$

where $k_1'$ is the tip-surface spring constant in liquid. The contribution from the conical part of the tip and cantilever is absent for $R \gg \lambda_D$. Note that the increase in response observed at the contact point in liquid [Fig. 2(b)] is due to additional electrostatic coupling in the double layer. The response decreases with increasing force due to the increased contact stiffness.

The electromechanical response in liquid is described by Eq. (2), where the tip-surface spring constant now includes the effect of the liquid layer. The screening coefficient is
\( \alpha(h) = 1 \) in Eq. (2) for \( h \ll \lambda_D \), i.e., when the tip touches the surface, and is \( \alpha(h) = 0 \) if the electric double layers around the tip and the surface do not overlap. Thus, the electromechanical response [Eq. (2)] in solution gradually decays at distances on the order of the Debye length of the solution, and the electrostatic contribution is reduced as compared to ambient imaging [Fig. 4(d)].

The absence of PFM contrast in high concentrations of NaCl and the stiffening of the tip-surface contact for high indentation forces suggest that in liquid PFM the tip is separated from the surface by a liquid layer of thickness \( \delta \sim 1-3 \) nm formed due to interactions between the hydrophobic gold tip and the hydrophilic PZT surface \([25,26]\). The PFM contrast disappears for \( \lambda_D \ll \delta \), i.e., at high NaCl solution concentrations. The thickness, \( \delta \), provides a lower boundary for PFM resolution. The presence of the water layer also prevents the transfer of in-plane sample oscillations to the tip via tip torsion and, indeed, no lateral PFM signal was detected.

To summarize, we have demonstrated electromechanical imaging in a liquid environment with \( \sim 3 \) nm resolution and elucidated the image formation mechanisms. The mobile ions present in the solution effectively screen the long-range electrostatic interactions at distances greater than the Debye length, thus localizing the ac field to the tip-surface junction. This novel mechanism of electromechanical tip-surface interactions enables high spatial resolutions approaching the intrinsic ferroelectric domain-wall width limit. It is shown that electromechanical imaging using high \( (> 2) \) order cantilever resonances minimizes both the added mass and hydrodynamic damping effects on cantilever dynamics, and provides a signal level comparable to ambient conditions. The elimination of capillary interactions and the control of van der Waals tip-surface forces in a liquid environment allow precise control of tip-surface separation and contact stiffnesses, which are essential for successful molecular-resolution imaging. We believe that electromechanical imaging in liquids is the key to achieving domain-wall width resolutions in perovskites and molecular resolution in soft polymers and biological systems.

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[16] The only published attempt for PFM in liquid is by Ganpule, when a highly conductive liquid was used as a top electrode, C. Ganpule, Ph.D. thesis, University of Maryland, College Park, 2001.